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Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

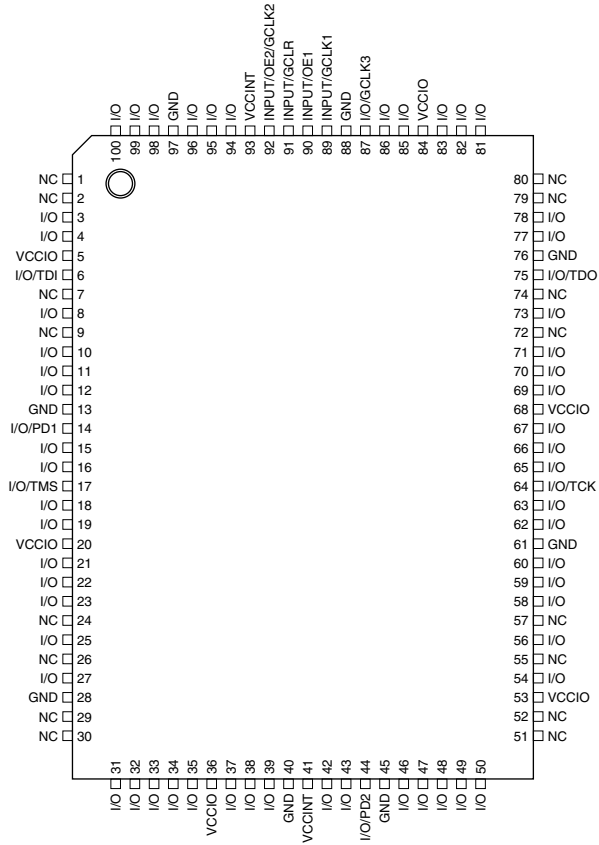
Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

Applications of Embedded - CPLDs

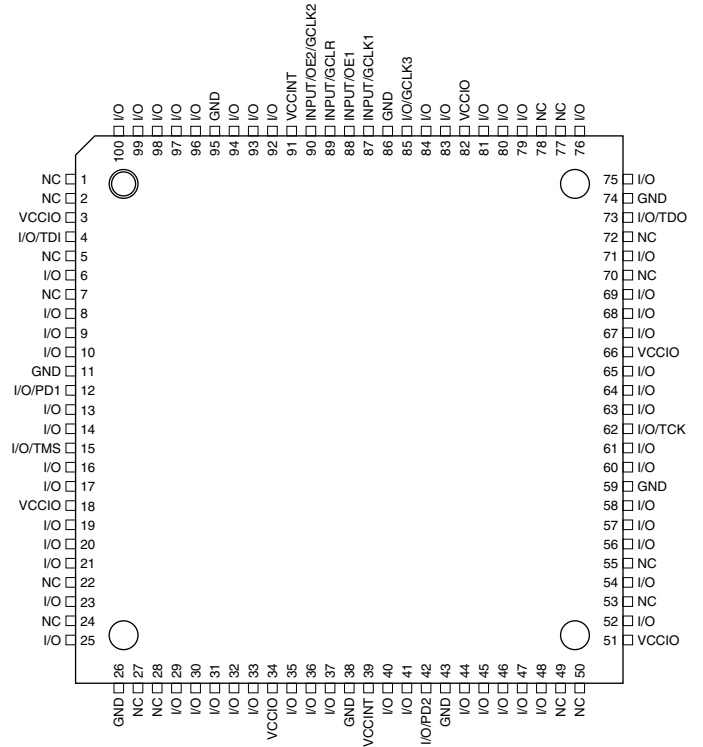
Details

Product Status	Obsolete
Programmable Type	In System Programmable (min 10K program/erase cycles)
Delay Time tpd(1) Max	25 ns
Voltage Supply - Internal	4.5V ~ 5.5V
Number of Logic Elements/Blocks	-
Number of Macrocells	64
Number of Gates	-
Number of I/O	48
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	68-LCC (J-Lead)
Supplier Device Package	68-PLCC (24.23x24.23)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/atf1504asl-25ji68

**100-lead PQFP
Top View**



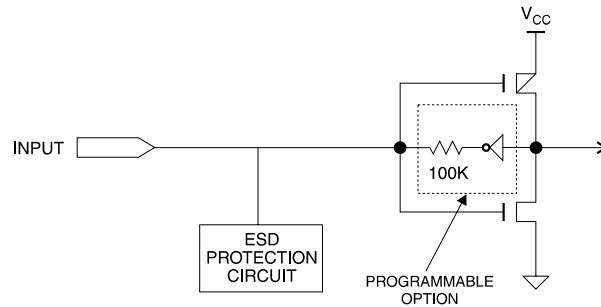
**100-lead TQFP
Top View**



Programmable Pin-keeper Option for Inputs and I/Os

The ATF1504AS offers the option of programming all input and I/O pins so that pin-keeper circuits can be utilized. When any pin is driven high or low and then subsequently left floating, it will stay at that previous high- or low-level. This circuitry prevents unused input and I/O lines from floating to intermediate voltage levels, which causes unnecessary power consumption and system noise. The keeper circuits eliminate the need for external pull-up resistors and eliminate their DC power consumption.

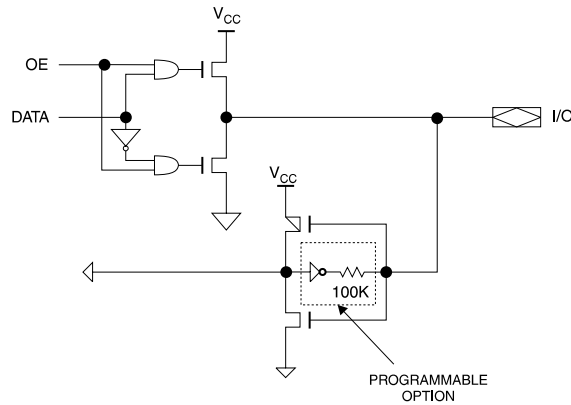
Input Diagram



Speed/Power Management

The ATF1504AS has several built-in speed and power management features. The ATF1504AS contains circuitry that automatically puts the device into a low-power standby mode when no logic transitions are occurring. This not only reduces power consumption during inactive periods, but also provides proportional power savings for most applications running at system speeds below 5 MHz. This feature may be selected as a device option.

I/O Diagram



To further reduce power, each ATF1504AS macrocell has a Reduced Power bit feature. This feature allows individual macrocells to be configured for maximum power savings. This feature may be selected as a design option.

All ATF1504AS also have an optional power-down mode. In this mode, current drops to below 10 mA. When the power-down option is selected, either PD1 or PD2 pins (or both) can be used to power-down the part. The power-down option is selected in the design source file. When enabled, the device goes into power-down when either PD1 or PD2 is high. In the power-down mode, all internal logic signals are latched and held, as are any enabled outputs.

All pin transitions are ignored until the PD pin is brought low. When the power-down feature is enabled, the PD1 or PD2 pin cannot be used as a logic input or output. However, the pin's macrocell may still be used to generate buried foldback and cascade logic signals.

All power-down AC characteristic parameters are computed from external input or I/O pins, with Reduced Power Bit turned on. For macrocells in reduced-power mode (reduced-power bit turned on), the reduced-power adder, tRPA, must be added to the AC parameters, which include the data paths t_{LAD} , t_{LAC} , t_{IC} , t_{ACL} , t_{ACH} and t_{SEXP} .

The ATF1504AS macrocell also has an option whereby the power can be reduced on a per macrocell basis. By enabling this power-down option, macrocells that are not used in an application can be turned-down, thereby reducing the overall power consumption of the device.

Each output also has individual slew rate control. This may be used to reduce system noise by slowing down outputs that do not need to operate at maximum speed. Outputs default to slow switching, and may be specified as fast switching in the design file.

Design Software Support

ATF1504AS designs are supported by several industry-standard third-party tools. Automated fitters allow logic synthesis using a variety of high level description languages and formats.

Power-up Reset

The ATF1504AS is designed with a power-up reset, a feature critical for state machine initialization. At a point delayed slightly from V_{CC} crossing V_{RST} , all registers will be initialized, and the state of each output will depend on the polarity of its buffer. However, due to the asynchronous nature of reset and uncertainty of how V_{CC} actually rises in the system, the following conditions are required:

1. The V_{CC} rise must be monotonic,
2. After reset occurs, all input and feedback setup times must be met before driving the clock pin high, and,
3. The clock must remain stable during T_D .

The ATF1504AS has two options for the hysteresis about the reset level, V_{RST} , Small and Large. During the fitting process users may configure the device with the Power-up Reset hysteresis set to Large or Small. Atmel POF2JED users may select the Large option by including the flag "-power_reset" on the command line after "filename.POF". To allow the registers to be properly reinitialized with the Large hysteresis option selected, the following condition is added:

4. If V_{CC} falls below 2.0V, it must shut off completely before the device is turned on again.

When the Large hysteresis option is active, I_{CC} is reduced by several hundred microamps as well.

Security Fuse Usage

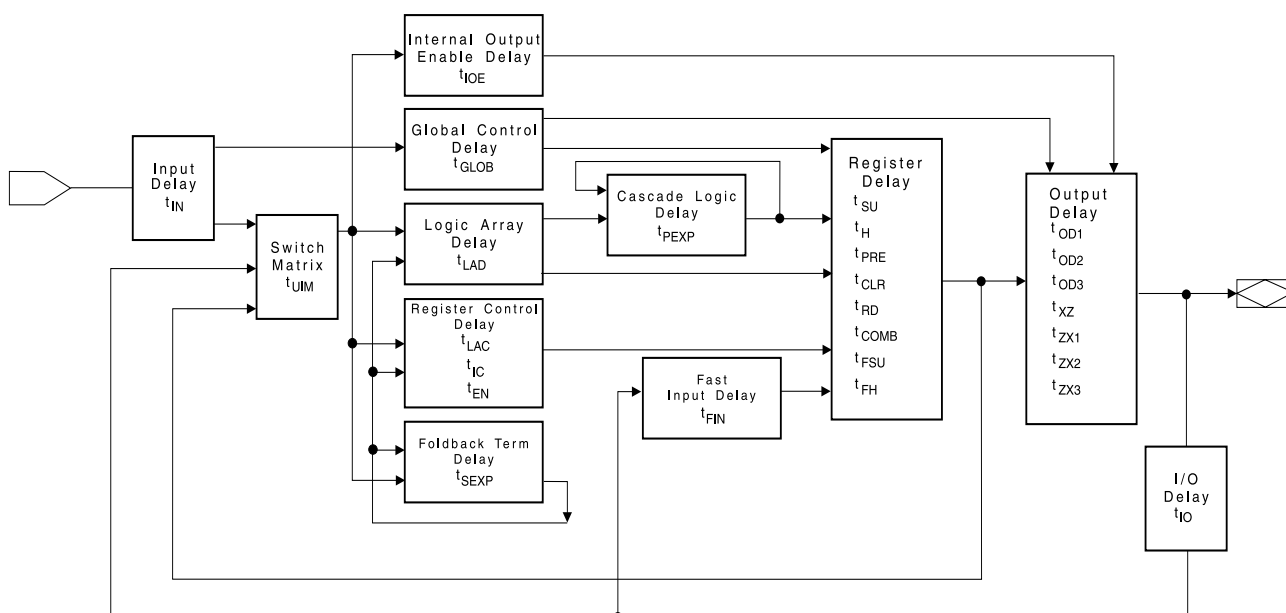
A single fuse is provided to prevent unauthorized copying of the ATF1504AS fuse patterns. Once programmed, fuse verify is inhibited. However, the 16-bit User Signature remains accessible.

AC Characteristics (Continued)

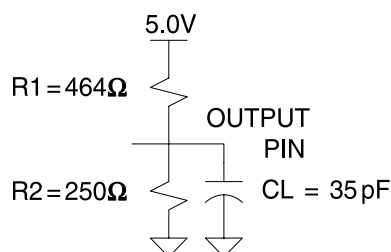
Symbol	Parameter	-7		-10		-15		-20		-25		Units
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
f_{MAX}	Maximum Clock Frequency	166.7		125		100		83.3		60		MHz
t_{IN}	Input Pad and Buffer Delay		0.5		0.5		2		2		2	ns
t_{IO}	I/O Input Pad and Buffer Delay		0.5		0.5		2		2		2	ns
t_{FIN}	Fast Input Delay		1		1		2		2		2	ns
t_{SEXP}	Foldback Term Delay		4		5		8		10		12	ns
t_{PEXP}	Cascade Logic Delay		0.8		0.8		1		1		1.2	ns
t_{LAD}	Logic Array Delay		3		5		6		7		8	ns
t_{LAC}	Logic Control Delay		3		5		6		7		8	ns
t_{IOE}	Internal Output Enable Delay		2		2		3		3		4	ns
t_{OD1}	Output Buffer and Pad Delay (Slow slew rate = OFF; $V_{\text{CCIO}} = 5\text{V}$; $C_L = 35\text{ pF}$)		2		1.5		4		5		6	ns
t_{OD2}	Output Buffer and Pad Delay (Slow slew rate = OFF; $V_{\text{CCIO}} = 3.3\text{V}$; $C_L = 35\text{ pF}$)		2.5		2.0		5		6		7	ns
t_{OD3}	Output Buffer and Pad Delay (Slow slew rate = ON; $V_{\text{CCIO}} = 5\text{V}$ or 3.3V ; $C_L = 35\text{ pF}$)		5		5.5		8		10		10	ns

Note: See ordering information for valid part numbers.

Timing Model



Output AC Test Loads



Note: *Numbers in parenthesis refer to 3.0V operating conditions (preliminary).

Power-down Mode

The ATF1504AS includes an optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin. When the PD pin is high, the device supply current is reduced to less than 10 mA. During power-down, all output data and internal logic states are latched internally and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in a high-Z state at the onset will remain at high-Z. During power-down, all input signals except the power-down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The power-down mode feature is enabled in the logic design file or as a fitted or translated s/w option. Designs using the power-down pin may not use the PD pin as a logic array input. However, all other PD pin macrocell resources may still be used, including the buried feedback and foldback product term array inputs.

Power Down AC Characteristics⁽¹⁾⁽²⁾

Symbol	Parameter	-7		-10		-15		-20		-25		Units
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
t_{IVDH}	Valid I, I/O before PD High	7		10		15		20		25		ns
$t_{GV DH}$	Valid OE ⁽²⁾ before PD High	7		10		15		20		25		ns
t_{CVDH}	Valid Clock ⁽²⁾ before PD High	7		10		15		20		25		ns
t_{DHIX}	I, I/O Don't Care after PD High		12		15		25		30		35	ns
t_{DHGX}	OE ⁽²⁾ Don't Care after PD High		12		15		25		30		35	ns
t_{DHCX}	Clock ⁽²⁾ Don't Care after PD High		12		15		25		30		35	ns
t_{DLIV}	PD Low to Valid I, I/O		1		1		1		1		1	μs
t_{DLGV}	PD Low to Valid OE (Pin or Term)		1		1		1		1		1	μs
t_{DLCV}	PD Low to Valid Clock (Pin or Term)		1		1		1		1		1	μs
t_{DLOV}	PD Low to Valid Output		1		1		1		1		1	μs

- Notes:
1. For slow slew outputs, add t_{SSO} .
 2. Pin or product term.
 3. Includes t_{RPA} due to reduced power bit enabled.

JTAG-BST/ISP Overview

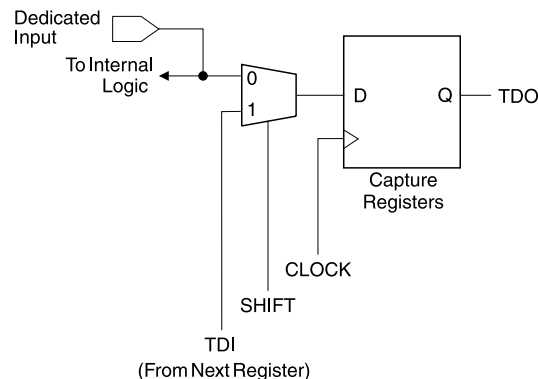
The JTAG boundary-scan testing is controlled by the Test Access Port (TAP) controller in the ATF1504AS. The boundary-scan technique involves the inclusion of a shift-register stage (contained in a boundary-scan cell) adjacent to each component so that signals at component boundaries can be controlled and observed using scan testing principles. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary scan testing. The ATF1504AS does not currently include a Test Reset (TRST) input pin because the TAP controller is automatically reset at power-up. The five JTAG modes supported include: SAMPLE/PRELOAD, EXTEST, BYPASS, IDCODE and HIGHZ. The ATF1504AS's ISP can be fully described using JTAG's BSDL as described in IEEE Standard 1149.1b. This allows ATF1504AS programming to be described and implemented using any one of the third-party development tools supporting this standard.

The ATF1504AS has the option of using four JTAG-standard I/O pins for boundary-scan testing (BST) and in-system programming (ISP) purposes. The ATF1504AS is programmable through the four JTAG pins using the IEEE standard JTAG programming protocol established by IEEE Standard 1149.1 using 5V TTL-level programming signals from the ISP interface for in-system programming. The JTAG feature is a programmable option. If JTAG (BST or ISP) is not needed, then the four JTAG control pins are available as I/O pins.

JTAG Boundary-scan Cell (BSC) Testing

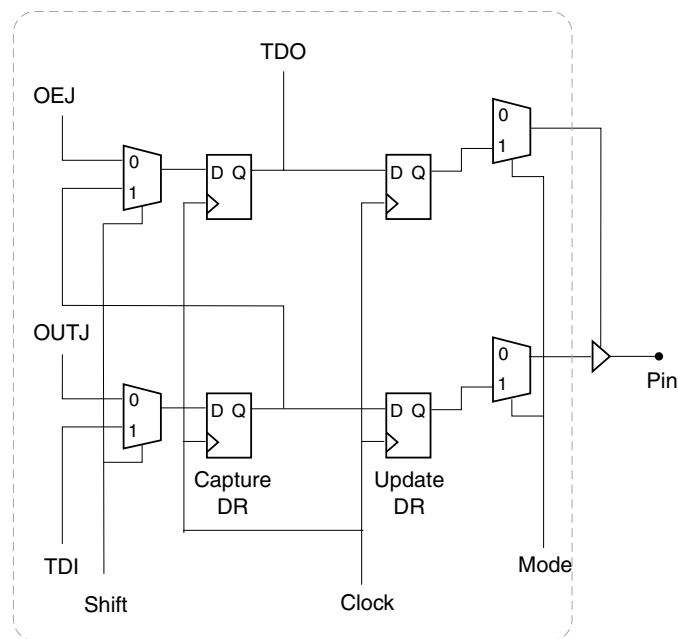
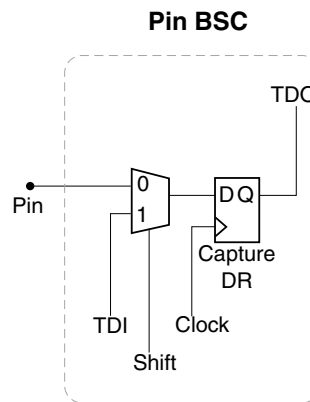
The ATF1504AS contains up to 68 I/O pins and four input pins, depending on the device type and package type selected. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing as described in detail by IEEE Standard 1149.1. A typical BSC consists of three capture registers or scan registers and up to two update registers. There are two types of BSCs, one for input or I/O pin, and one for the macrocells. The BSCs in the device are chained together through the capture registers. Input to the capture register chain is fed in from the TDI pin while the output is directed to the TDO pin. Capture registers are used to capture active device data signals, to shift data in and out of the device and to load data into the update registers. Control signals are generated internally by the JTAG TAP controller. The BSC configuration for the input and I/O pins and macrocells are shown below.

BSC Configuration for Input and I/O Pins (Except JTAG TAP Pins)



Note: The ATF1504AS has pull-up option on TMS and TDI pins. This feature is selected as a design option.

BSC Configuration for Macrocell

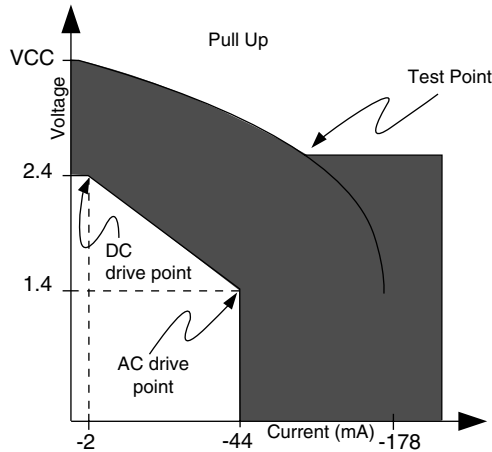


Macrocell BSC

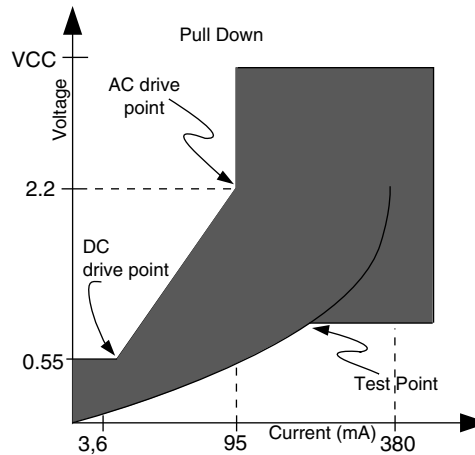
PCI Compliance

The ATF1504AS also supports the growing need in the industry to support the new Peripheral Component Interconnect (PCI) interface standard in PCI-based designs and specifications. The PCI interface calls for high current drivers, which are much larger than the traditional TTL drivers. In general, PLDs and FPGAs parallel outputs to support the high current load required by the PCI interface. The ATF1504AS allows this without contributing to system noise while delivering low output-to-output skew. Having a programmable high drive option is also possible without increasing output delay or pin capacitance. The PCI electrical characteristics appear on the next page.

PCI Voltage-to-current Curves for +5V Signaling in Pull-up Mode



PCI Voltage-to-current Curves for +5V Signaling in Pull-down Mode



PCI DC Characteristics

Symbol	Parameter	Conditions	Min	Max	Units
V_{CC}	Supply Voltage		4.75	5.25	V
V_{IH}	Input High Voltage		2.0	$V_{CC} + 0.5$	V
V_{IL}	Input Low Voltage		-0.5	0.8	V
I_{IH}	Input High Leakage Current	$V_{IN} = 2.7V$		70	μA
I_{IL}	Input Low Leakage Current	$V_{IN} = 0.5V$		-70	μA
V_{OH}	Output High Voltage	$I_{OUT} = -2\text{ mA}$	2.4		V
V_{OL}	Output Low Voltage	$I_{OUT} = 3\text{ mA}, 6\text{ mA}$		0.55	V
C_{IN}	Input Pin Capacitance			10	pF
C_{CLK}	CLK Pin Capacitance			12	pF
C_{IDSEL}	IDSEL Pin Capacitance			8	pF
L_{PIN}	Pin Inductance			20	nH

Note: Leakage current is with pin-keeper off.

PCI AC Characteristics

Symbol	Parameter	Conditions	Min	Max	Units
$I_{OH(AC)}$	Switching Current High (Test High)	$0 < V_{OUT} \leq 1.4$	-44		mA
		$1.4 < V_{OUT} < 2.4$	$-44 + (V_{OUT} - 1.4)/0.024$		mA
		$3.1 < V_{OUT} < V_{CC}$		Equation A	mA
		$V_{OUT} = 3.1V$		-142	μA
$I_{OL(AC)}$	Switching Current Low (Test Point)	$V_{OUT} > 2.2V$	95		mA
		$2.2 > V_{OUT} > 0$	$V_{OUT}/0.023$		mA
		$0.1 > V_{OUT} > 0$		Equation B	mA
		$V_{OUT} = 0.71$		206	mA
I_{CL}	Low Clamp Current	$-5 < V_{IN} \leq -1$	$-25 + (V_{IN} + 1)/0.015$		mA
$SLEW_R$	Output Rise Slew Rate	0.4V to 2.4V load	0.5	3	V/ns
$SLEW_F$	Output Fall Slew Rate	2.4V to 0.4V load	0.5	3	V/ns

- Notes:
- Equation A: $I_{OH} = 11.9 (V_{OUT} - 5.25) * (V_{OUT} + 2.45)$ for $V_{CC} > V_{OUT} > 3.1V$.
 - Equation B: $I_{OL} = 78.5 * V_{OUT} * (4.4 - V_{OUT})$ for $0V < V_{OUT} < 0.71V$.

ATF1504AS Dedicated Pinouts

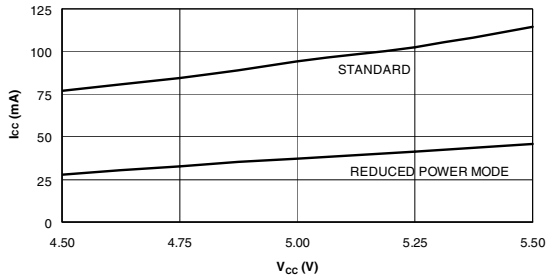
Dedicated Pin	44-lead TQFP	44-lead J-lead	68-lead J-lead	84-lead J-lead	100-lead PQFP	100-lead TQFP
INPUT/OE2/GCLK2	40	2	2	2	92	90
INPUT/GCLR	39	1	1	1	91	89
INPUT/OE1	38	44	68	84	90	88
INPUT/GCLK1	37	43	67	83	89	87
I/O /GCLK3	35	41	65	81	87	85
I/O/PD (1,2)	5, 19	11, 25	17, 37	20, 46	14, 44	12, 42
I/O/TDI (JTAG)	1	7	12	14	6	4
I/O/TMS (JTAG)	7	13	19	23	17	15
I/O/TCK (JTAG)	26	32	50	62	64	62
I/O/TDO (JTAG)	32	38	57	71	75	73
GND	4, 16, 24, 36	10, 22, 30, 42	6, 16, 26, 34, 38, 48, 58, 66	7, 19, 32, 42, 47, 59, 72, 82	13, 28, 40, 45, 61, 76, 88, 97	11, 26, 38, 43, 59, 74, 86, 95
V _{CCINT}	9, 17, 29, 41	3, 15, 23, 35	3, 35	3, 43	41, 93	39, 91
V _{CCIO}	—	—	11, 21, 31, 43, 53, 63	13, 26, 38, 53, 66, 78	5, 20, 36, 53, 68, 84	3, 18, 34, 51, 66, 82
N/C	—	—	—	—	1, 2, 7, 9, 24, 26, 29, 30, 51, 52, 55, 57, 72, 74, 79, 80	1, 2, 5, 7, 22, 24, 27, 28, 49, 50, 53, 55, 70, 72, 77, 78
# of Signal Pins	36	36	52	68	68	68
# User I/O Pins	32	32	48	64	64	64

OE (1, 2) Global OE Pins
 GCLR Global Clear Pin
 GCLK (1, 2, 3) Global Clock Pins
 PD (1, 2) Power down pins
 TDI, TMS, TCK, TDO JTAG pins used for boundary-scan testing or in-system programming
 GND Ground Pins
 V_{CCINT} VCC pins for the device (+5V - Internal)
 V_{CCIO} VCC pins for output drivers (for I/O pins) (+5V or 3.3V - I/Os)

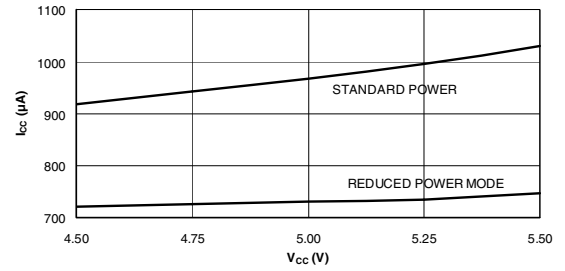
ATF1504AS I/O Pinouts

MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100-lead PQFP	100-lead TQFP	MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100-lead PQFP	100-lead TQFP
1	A	12	6	18	22	16	14	33	C	24	18	36	44	42	40
2	A	—	—	—	21	15	13	34	C	—	—	—	45	43	41
3	A/ PD1	11	5	17	20	14	12	35	C/ PD2	25	19	37	46	44	42
4	A	9	3	15	18	12	10	36	C	26	20	39	48	46	44
5	A	8	2	14	17	11	9	37	C	27	21	40	49	47	45
6	A	—	—	13	16	10	8	38	C	—	—	41	50	48	46
7	A	—	—	—	15	8	6	39	C	—	—	—	51	49	47
8/ TDI	A	7	1	12	14	6	4	40	C	28	22	42	52	50	48
9	A	—	—	10	12	4	100	41	C	29	23	44	54	54	52
10	A	—	—	—	11	3	99	42	C	—	—	—	55	56	54
11	A	6	44	9	10	100	98	43	C	—	—	45	56	58	56
12	A	—	—	8	9	99	97	44	C	—	—	46	57	59	57
13	A	—	—	7	8	98	96	45	C	—	—	47	58	60	58
14	A	5	43	5	6	96	94	46	C	31	25	49	60	62	60
15	A	—	—	—	5	95	93	47	C	—	—	—	61	63	61
16	A	4	42	4	4	94	92	48/ TCK	C	32	26	50	62	64	62
17	B	21	15	33	41	39	37	49	D	33	27	51	63	65	63
18	B	—	—	—	40	38	36	50	D	—	—	—	64	66	64
19	B	20	14	32	39	37	35	51	D	34	28	52	65	67	65
20	B	19	13	30	37	35	33	52	D	36	30	54	67	69	67
21	B	18	12	29	36	34	32	53	D	37	31	55	68	70	68
22	B	—	—	28	35	33	31	54	D	—	—	56	69	71	69
23	B	—	—	—	34	32	30	55	D	—	—	—	70	73	71
24	B	17	11	27	33	31	29	56/ TDO	D	38	32	57	71	75	73
25	B	16	10	25	31	27	25	57	D	39	33	59	73	77	75
26	B	—	—	—	30	25	23	58	D	—	—	—	74	78	76
27	B	—	—	24	29	23	21	59	D	—	—	60	75	81	79
28	B	—	—	23	28	22	20	60	D	—	—	61	76	82	80
29	B	—	—	22	27	21	19	61	D	—	—	62	77	83	81
30	B	14	8	20	25	19	17	62	D	40	34	64	79	85	83
31	B	—	—	—	24	18	16	63	D	—	—	—	80	86	84
32/ TMS	B	13	7	19	23	17	15	64	D/ GCLK3	41	35	65	81	87	85

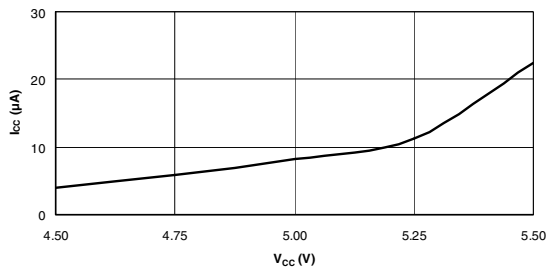
SUPPLY CURRENT VS. SUPPLY VOLTAGE
($T_A = 25^\circ\text{C}$, $F = 0$)



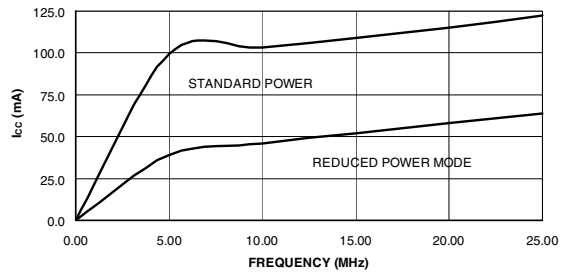
SUPPLY CURRENT VS. SUPPLY VOLTAGE
PIN-CONTROLLED POWER-DOWN MODE
($T_A = 25^\circ\text{C}$, $F = 0$)



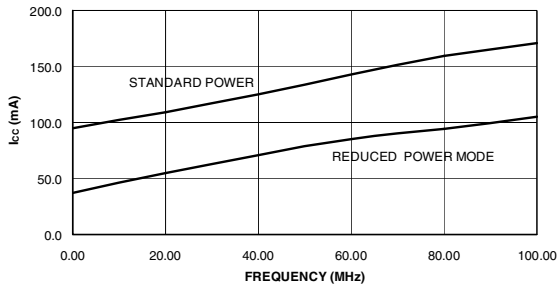
SUPPLY CURRENT VS. SUPPLY VOLTAGE
LOW-POWER ("L") VERSION
($T_A = 25^\circ\text{C}$, $F = 0$)



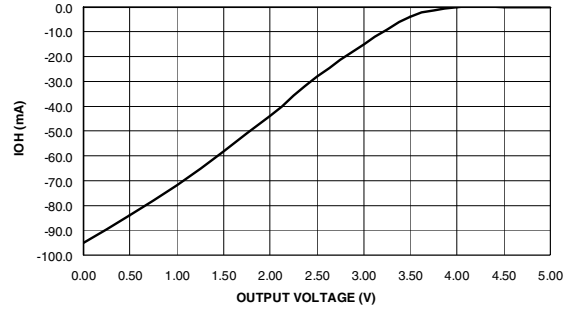
SUPPLY CURRENT VS. FREQUENCY
LOW-POWER ("L") VERSION
LOW POWER ($T_A = 25^\circ\text{C}$)



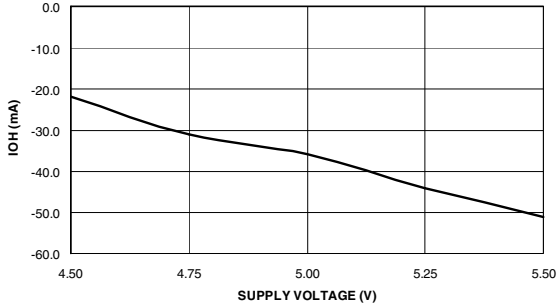
SUPPLY CURRENT VS. FREQUENCY
STANDARD POWER ($T_A = 25^\circ\text{C}$)



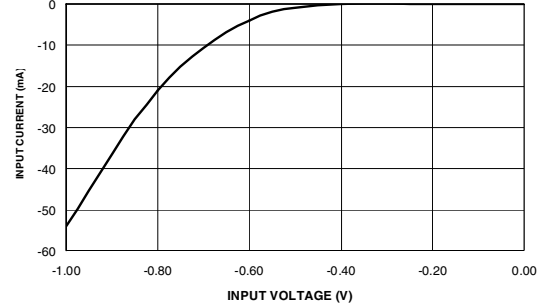
OUTPUT SOURCE CURRENT VS. OUTPUT VOLTAGE
($V_{CC} = 5\text{V}$, $T_A = 25^\circ\text{C}$)



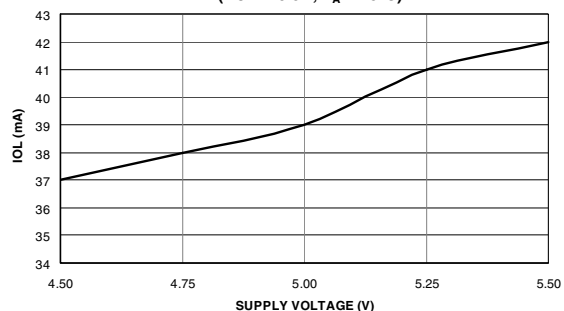
OUTPUT SOURCE CURRENT VS. SUPPLY VOLTAGE
($V_{OH} = 2.4\text{V}$, $T_A = 25^\circ\text{C}$)



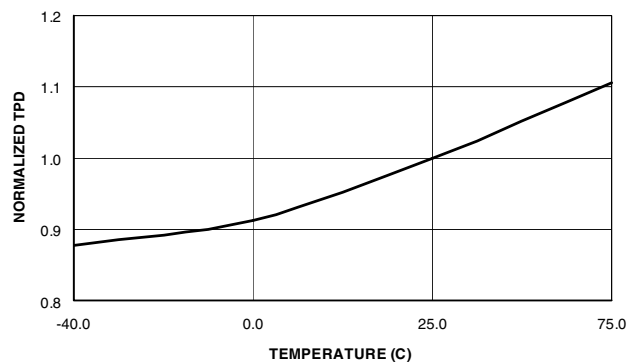
INPUT CLAMP CURRENT VS. INPUT VOLTAGE
($V_{CC} = 5\text{V}$, $T_A = 25^\circ\text{C}$)



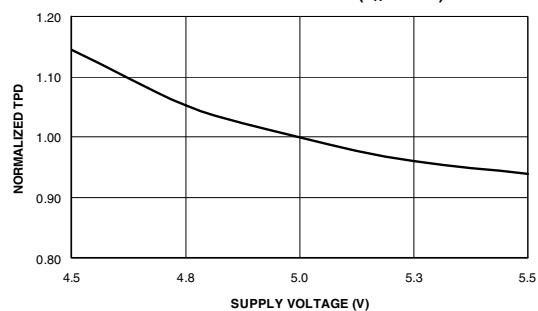
OUTPUT SINK CURRENT VS. SUPPLY VOLTAGE
($V_{OL} = 0.5V$, $T_A = 25^\circ C$)



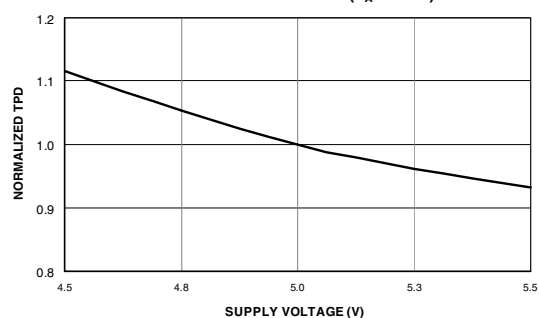
NORMALIZED TPD
VS. TEMPERATURE ($V_{CC} = 5.0V$)



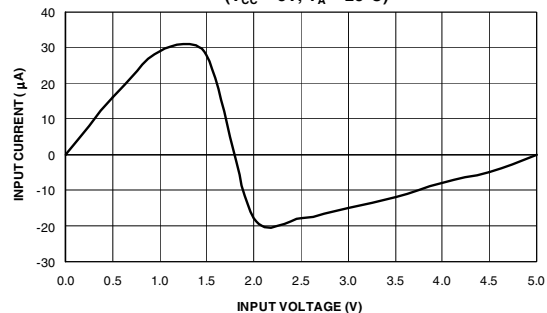
NORMALIZED TPD
VS. SUPPLY VOLTAGE ($T_A = 25^\circ C$)



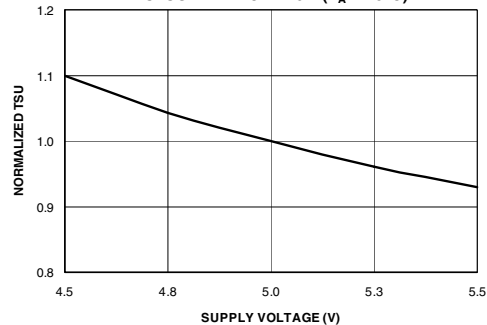
NORMALIZED TCO
VS. SUPPLY VOLTAGE ($T_A = 25^\circ C$)



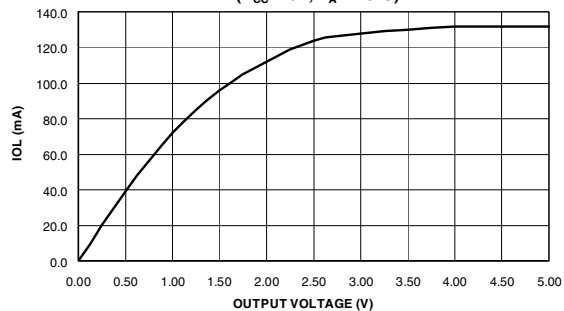
INPUT CURRENT VS. INPUT VOLTAGE
($V_{CC} = 5V$, $T_A = 25^\circ C$)

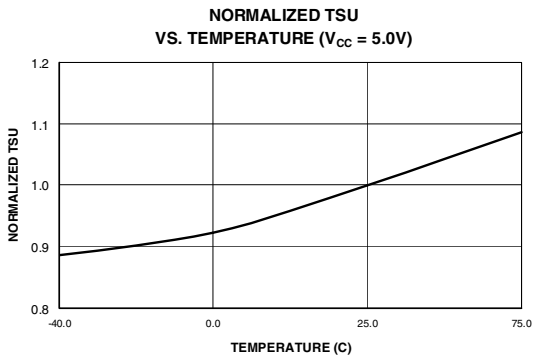
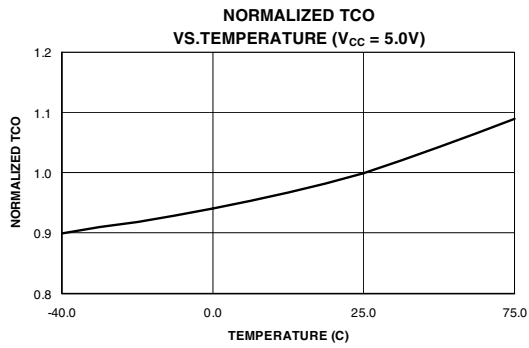


NORMALIZED TSU
VS. SUPPLY VOLTAGE ($T_A = 25^\circ C$)



OUTPUT SINK CURRENT VS. OUTPUT VOLTAGE
($V_{CC} = 5V$, $T_A = 25^\circ C$)





ATF1504AS Ordering Information

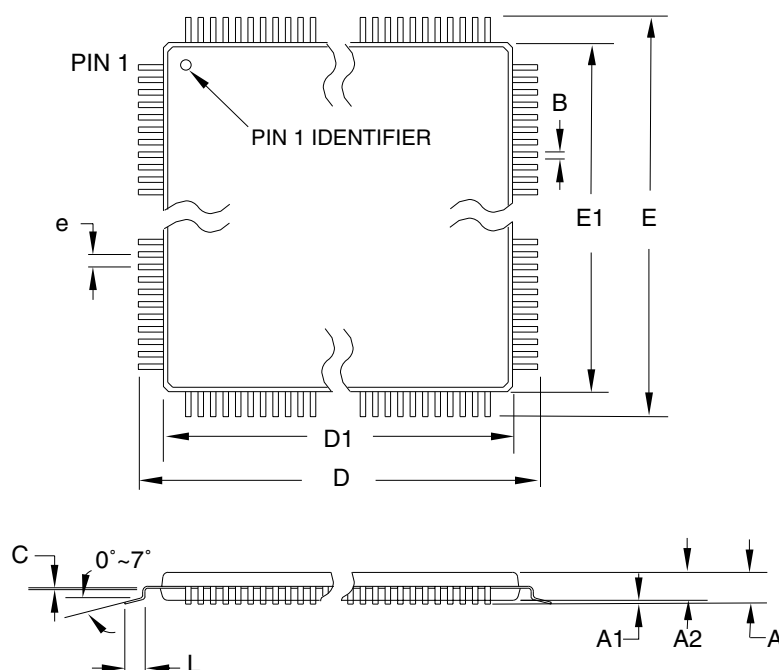
t_{PD} (ns)	t_{CO1} (ns)	f_{MAX} (MHz)	Ordering Code	Package	Operation Range
7.5	4.5	166.7	ATF1504AS-7 AC44 ATF1504AS-7 JC44 ATF1504AS-7 JC68 ATF1504AS-7 JC84 ATF1504AS-7 QC100 ATF1504AS-7 AC100	44A 44J 68J 84J 100Q1 100A	Commercial (0°C to 70°C)
10	5	125	ATF1504AS-10 AC44 ATF1504AS-10 JC44 ATF1504AS-10 JC68 ATF1504AS-10 JC84 ATF1504AS-10 QC100 ATF1504AS-10 AC100	44A 44J 68J 84J 100Q1 100A	Commercial (0°C to 70°C)
10	5	125	ATF1504AS-10 AI44 ATF1504AS-10 JI44 ATF1504AS-10 JI68 ATF1504AS-10 JI84 ATF1504AS-10 QI100 ATF1504AS-10 AI100	44A 44J 68J 84J 100Q1 100A	Industrial (-40°C to +85°C)
15	8	100	ATF1504AS-15 AC44 ATF1504AS-15 JC44 ATF1504AS-15 JC68 ATF1504AS-15 JC84 ATF1504AS-15 QC100 ATF1500AS-15 AC100	44A 44J 68J 84J 100Q1 100A	Commercial (0°C to 70°C)
15	8	100	ATF1504AS-15 AI44 ATF1504AS-15 JI44 ATF1504AS-15 JI68 ATF1504AS-15 JI84 ATF1504AS-15 QI100 ATF1504AS-15 AI100	44A 44J 68J 84J 100Q1 100A	Industrial (-40°C to +85°C)

Using “C” Product for Industrial

To use commercial product for Industrial temperature ranges, down-grade one speed grade from the “I” to the “C” device (7 ns “C” = 10 ns “I”) and de-rate power by 30%.

Packaging Information

44A – TQFP



COMMON DIMENSIONS
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	–	–	1.20	
A1	0.05	–	0.15	
A2	0.95	1.00	1.05	
D	11.75	12.00	12.25	
D1	9.90	10.00	10.10	Note 2
E	11.75	12.00	12.25	
E1	9.90	10.00	10.10	Note 2
B	0.30	–	0.45	
C	0.09	–	0.20	
L	0.45	–	0.75	
e	0.80 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-026, Variation ACB.
 2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is 0.25 mm per side. Dimensions D1 and E1 are maximum plastic body size dimensions including mold mismatch.
 3. Lead coplanarity is 0.10 mm maximum.

10/5/2001



2325 Orchard Parkway
San Jose, CA 95131

TITLE

44A, 44-lead, 10 x 10 mm Body Size, 1.0 mm Body Thickness,
0.8 mm Lead Pitch, Thin Profile Plastic Quad Flat Package (TQFP)

DRAWING NO.

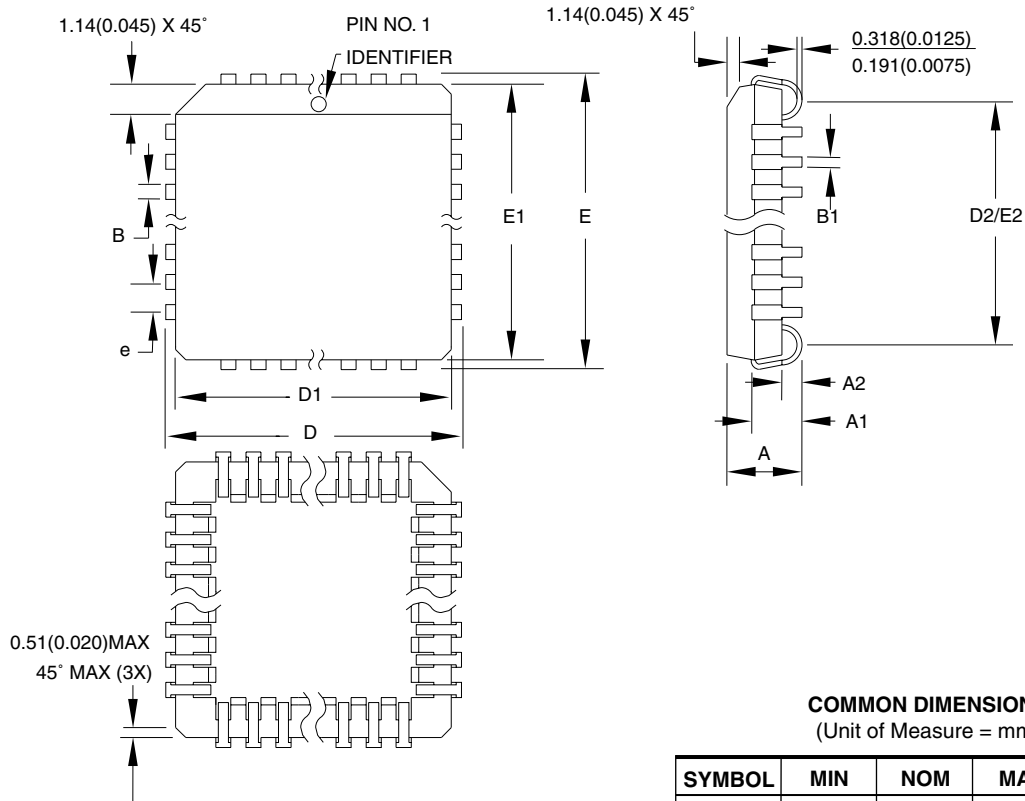
44A

REV.

B



44J – PLCC



COMMON DIMENSIONS
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	17.399	—	17.653	
D1	16.510	—	16.662	Note 2
E	17.399	—	17.653	
E1	16.510	—	16.662	Note 2
D2/E2	14.986	—	16.002	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AC.
 2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
 3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



2325 Orchard Parkway
San Jose, CA 95131

TITLE

44J, 44-lead, Plastic J-leaded Chip Carrier (PLCC)

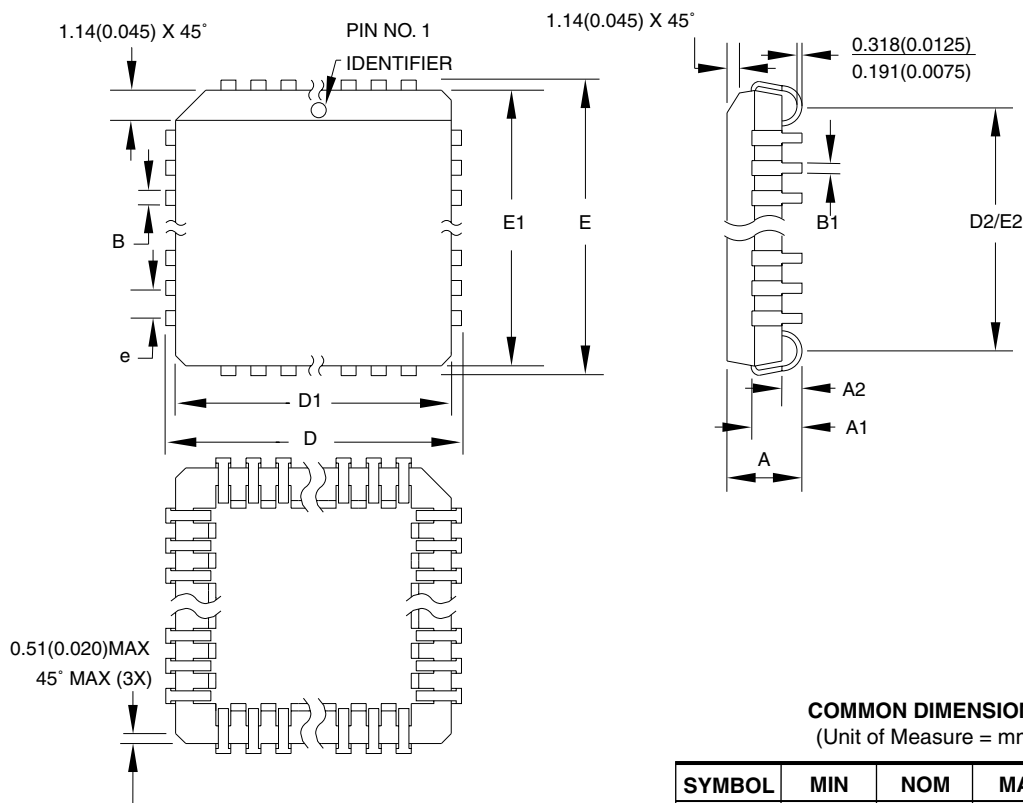
DRAWING NO.

44J

REV.

B

68J – PLCC



COMMON DIMENSIONS
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	25.019	—	25.273	
D1	24.130	—	24.333	Note 2
E	25.019	—	25.273	
E1	24.130	—	24.333	Note 2
D2/E2	22.606	—	23.622	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AE.
 2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
 3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



2325 Orchard Parkway
San Jose, CA 95131

TITLE

68J, 68-lead, Plastic J-leaded Chip Carrier (PLCC)

DRAWING NO.

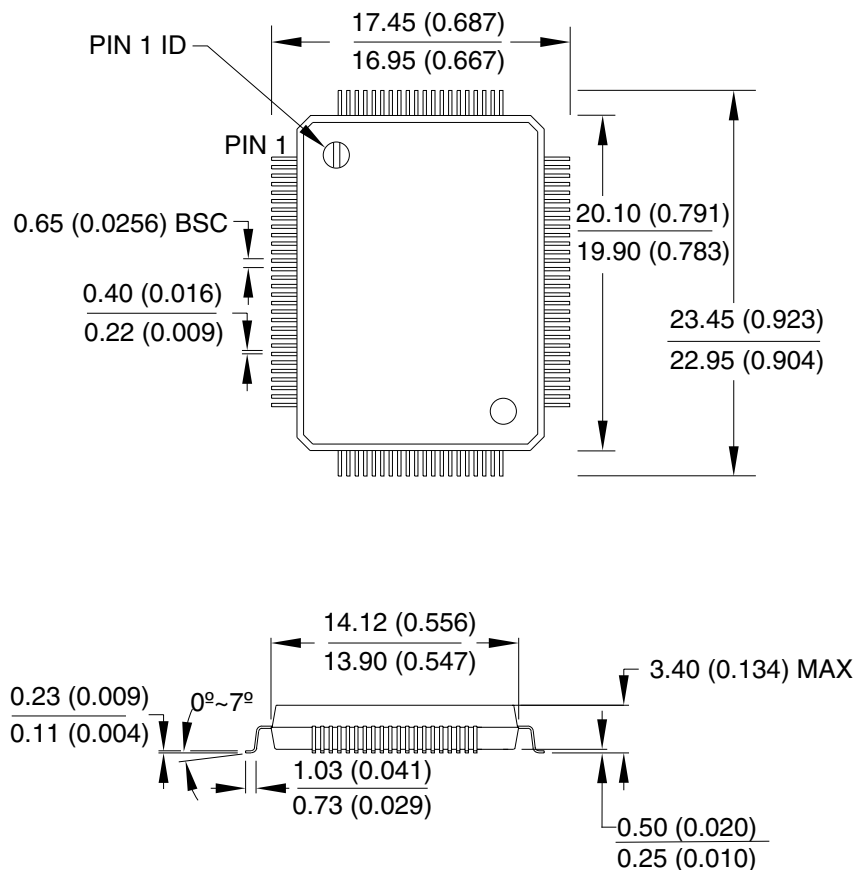
68J

REV.

B

100Q1 – PQFP

Dimensions in Millimeters and (Inches)*
 *Controlling dimensions: millimeters
 JEDEC STANDARD MS-022, GC-1



04/11/2001



2325 Orchard Parkway
 San Jose, CA 95131

TITLE

100Q1, 100-lead, 14 x 20 mm Body, 3.2 mm Footprint, 0.65 mm Pitch,
 Plastic Quad Flat Package (PQFP)

DRAWING NO.

100Q1

REV.

A





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